

HF-VHF power MOS transistor

BLF242

FEATURES

- · High power gain
- · Low noise
- · Easy power control
- · Good thermal stability
- · Withstands full load mismatch
- Gold metallization ensures excellent reliability.

DESCRIPTION

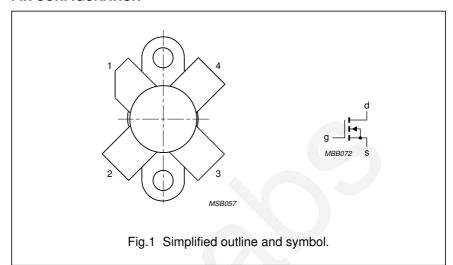
Silicon N-channel enhancement mode vertical D-MOS transistor designed for professional transmitter applications in the HF/VHF frequency range.

The transistor is encapsulated in a 4-lead, SOT123A flange package, with a ceramic cap. All leads are isolated from the flange.

PINNING - SOT123A

PIN	DESCRIPTION
1	drain
2	source
3	gate
4	source

PIN CONFIGURATION



CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A, and SNW-FQ-302B.

WARNING	
Product and environmental safety - toxic materials	

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

QUICK REFERENCE DATA

RF performance at T_h = 25 °C in a common source test circuit.

MODE OF OPERATION	f	V _{DS}	P _L	G _p	η _D
	(MHz)	(V)	(W)	(dB)	(%)
CW, class-B	175	28	5	>13 typ. 16	>50 typ. 60



Island Labs

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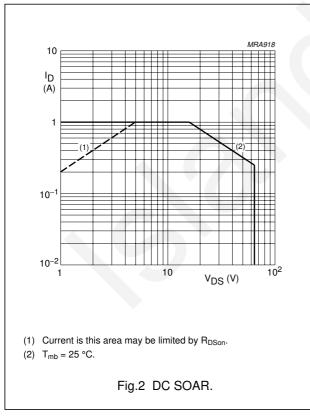
LIMITING VALUES

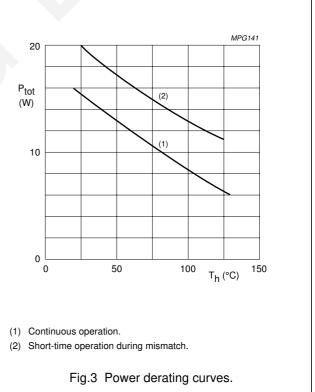
In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	65	٧
V _{GS}	gate-source voltage		_	±20	٧
I _D	drain current (DC)		_	1	Α
P _{tot}	total power dissipation	T _{mb} ≤ 25 °C	-	16	W
T _{stg}	storage temperature		-65	150	°C
Tj	junction temperature		_	200	°C

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-mb}	thermal resistance from junction to mounting base	$T_{mb} = 25 ^{\circ}\text{C}; P_{tot} = 16 \text{W}$	11	K/W
R _{th mb-h}	thermal resistance from mounting base to heatsink	$T_{mb} = 25 ^{\circ}\text{C}; P_{tot} = 16 \text{W}$	0.3	K/W





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CHARACTERISTICS

 $T_j = 25$ °C unless otherwise specified.

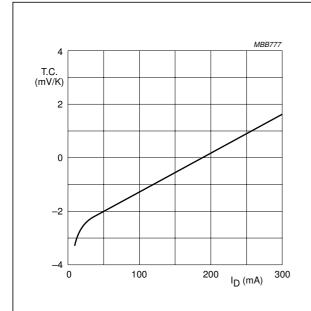
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{(BR)DSS}	drain-source breakdown voltage	V _{GS} = 0; I _D = 0.1 mA	65	-	-	٧
I _{DSS}	drain-source leakage current	V _{GS} = 0; V _{DS} = 28 V	-	_	10	μΑ
I _{GSS}	gate-source leakage current	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0$	_	_	1	μΑ
V_{GSth}	gate-source threshold voltage	$I_D = 3 \text{ mA}; V_{DS} = 10 \text{ V}$	2	_	4.5	V
9fs	forward transconductance	$I_D = 0.3 \text{ A}; V_{DS} = 10 \text{ V}$	0.16	0.24	-	S
R _{DSon}	drain-source on-state resistance	$I_D = 0.3 A; V_{GS} = 1 V$	-	3.3	5	Ω
I _{DSX}	on-state drain current	V _{GS} = 10 V; V _{GS} = 10 V	-	1.2	_	Α
C _{is}	input capacitance	$V_{GS} = 0$; $V_{DS} = 28 \text{ V}$; $f = 1 \text{ MHz}$	-	13	_	pF
C _{os}	output capacitance	V _{GS} = 0; V _{DS} = 28 V; f = 1 MHz	-	9.4	_	pF
C_{rs}	feedback capacitance	$V_{GS} = 0$; $V_{DS} = 28 \text{ V}$; $f = 1 \text{ MHz}$	-	1.7	_	pF

V_{GS} group indicator

GROUP		IITS /)	GROUP	LIMITS (V)		
	MIN.	MAX.		MIN.	MAX.	
А	2.0	2.1	0	3.3	3.4	
В	2.1	2.2	Р	3.4	3.5	
С	2.2	2.3	Q	3.5	3.6	
D	2.3	2.4	R	3.6	3.7	
E	2.4	2.5	S	3.7	3.8	
F	2.5	2.6	Т	3.8	3.9	
G	2.6	2.7	U	3.9	4.0	
Н	2.7	2.8	V	4.0	4.1	
J	2.8	2.9	W	4.1	4.2	
K	2.9	3.0	X	4.2	4.3	
L	3.0	3.1	Y	4.3	4.4	
M	3.1	3.2	Z	4.4	4.5	
N	3.2	3.3				

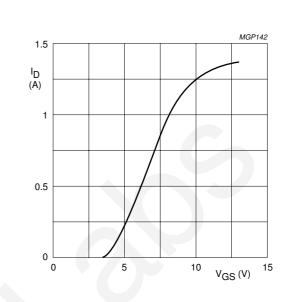
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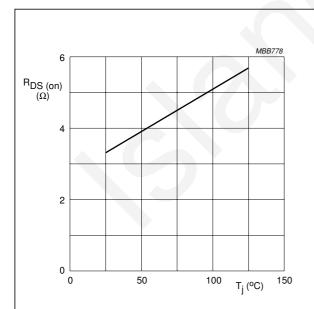
V_{DS} = 10 V.

Fig.4 Temperature coefficient of gate-source voltage as a function of drain current, typical values.



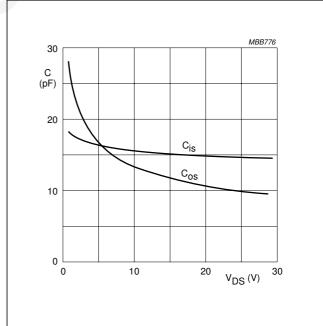
 $V_{DS} = 10 \text{ V}; T_j = 25 \text{ °C}.$

Fig.5 Drain current as a function of gate-source voltage, typical values.



 I_D = 0.3 A; V_{GS} = 10 V.

Fig.6 Drain-source on-state resistance as a function of junction temperature, typical values.

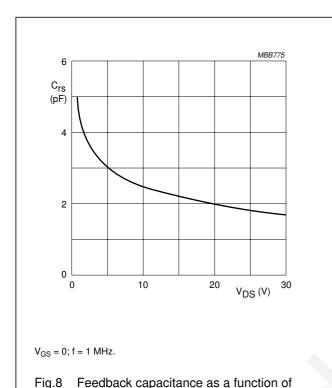


 $V_{GS} = 0$; f = 1 MHz.

Fig.7 Input and output capacitance as functions of drain-source voltage, typical values.

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APPLICATION INFORMATION FOR CLASS-B OPERATION

 $T_h = 25$ °C; $R_{th\ mb-h} = 0.3$ K/W; unless otherwise specified.

drain-source voltage, typical values.

RF performance in CW operation in a common source class-B test circuit.

MODE OF OPERATION	f (MHz)	V _{DS} (V)	I _{DQ} (mA)	P _L (W)	G _P (dB)	η _D (%)	R _{GS} (Ω)
CW, class-B	175	28	10	5	>13 typ. 16	>50 typ. 60	47

Ruggedness in class-B operation

The BLF242 is capable of withstanding a load mismatch corresponding to VSWR = 50 through all phases under the following conditions: $V_{DS} = 28 \text{ V}$; f = 175 MHz at rated output power.

Noise figure (see Fig.11)

 V_{DS} = 28 V; I_D = 0.2 A; f = 175 MHz; R_{GS} = 47 Ω ; T_h = 25 °C. Input and output power matched for P_L = 5 W; F = typ. 5.5 dB.

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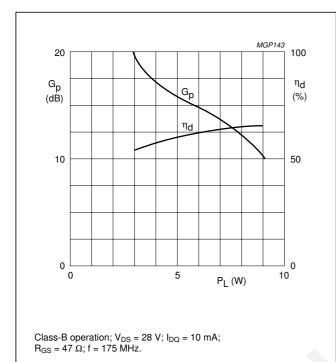
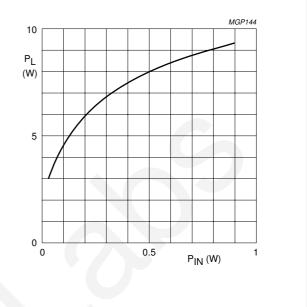
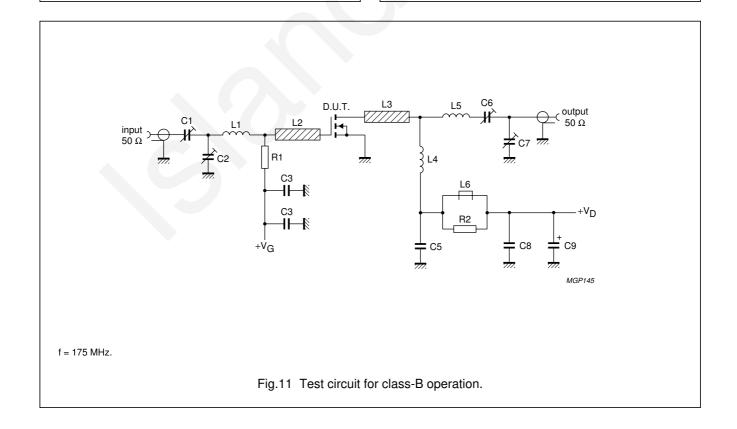


Fig.9 Power gain and efficiency as functions of load power, typical values.



Class-B operation; V_{DS} = 28 V; I_{DQ} = 10 mA; R_{GS} = 47 Ω ; f = 175 MHz.

Fig.10 Load power as a function of input power, typical values.



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List of components (see Fig.11)

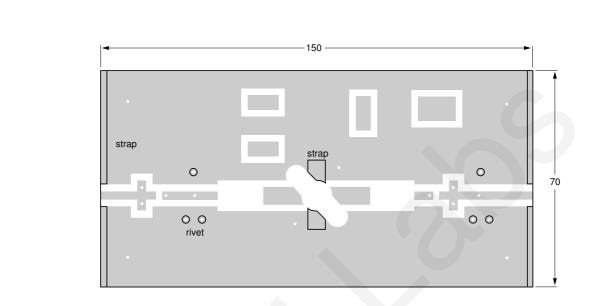
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C2, C7	film dielectric trimmer	4 to 40 pF		2222 809 08002
C3	multilayer ceramic chip capacitor; note 1	100 pF		
C4, C8	ceramic chip capacitor	100 nF		2222 852 47104
C6	film dielectric trimmer	5 to 60 pF		2222 809 08003
C9	electrolytic capacitor	2.2 μF, 40 V		
L1	5 turns enamelled 0.7 mm copper wire	53 nH	length 5.4 mm int. dia. 3 mm leads 2 × 5 mm	
L2, L3	stripline; note 2	30 Ω	10 × 6 mm	
L4	11 turns enamelled 1 mm copper wire	500 nH	length 15.5 mm int. dia. 8 mm leads 2 × 5 mm	
L5	5 turns enamelled 1 mm copper wire	79 nH	length 9.1 mm int. dia. 5 mm leads 2 × 5 mm	
L6	grade 3B Ferroxcube RF choke			4312 020 36640
R1	0.5 W metal film resistor	47 Ω		
R2	0.5 W metal film resistor	10 Ω		

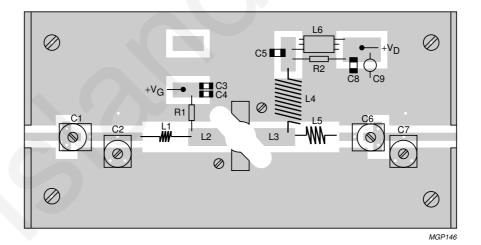
Notes

- 1. American Technical Ceramics (ATC) capacitor, type 100B or other capacitor of the same quality.
- 2. The striplines are on a double copper-clad printed circuit board, with epoxy fibre-glass dielectric (ϵ_r = 4.5), thickness 1/16 inch.

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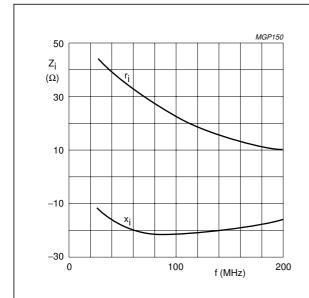
Dimensions in mm

The circuit and components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by fixing screws, copper straps and hollow rivets at the edges of the board and under the source.

Fig.12 Component layout for 175 MHz class-B test circuit.

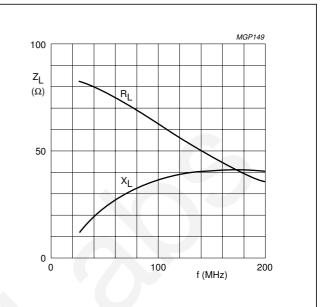
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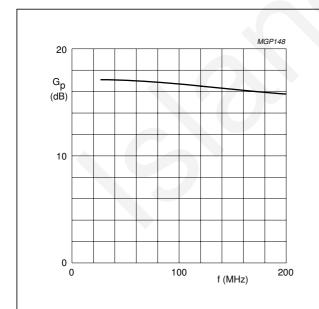
Class-B operation; V_{DS} = 28 V; P_L = 30 W; R_{GS} = 47 Ω ; T_h = 25 °C.

Fig.13 Input impedance as a function of frequency (series components), typical values.



Class-B operation; V_{DS} = 28 V; P_L = 30 W; R_{GS} = 47 Ω ; T_h = 25 °C.

Fig.14 Load impedance as a function of frequency (series components), typical values.



Class-B operation; V_{DS} = 28 V; P_L = 30 W; R_{GS} = 47 Ω ; T_h = 25 °C.

Fig.15 Power gain as a function of frequency, typical values.

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BLF242 scattering parameters

 $V_{DS} = 28 \text{ V}; I_D = 10 \text{ mA}; \text{ note 1}$

f (MHz)		s ₁₁	S	21	s	12	s ₂₂		
i (IVIIIZ)	S ₁₁	∠Φ	S ₂₁	∠Φ	s ₁₂	∠Φ	S ₂₂	∠Φ	
5	0.99	-3.40	5.57	177.10	0.01	87.60	1.00	-2.60	
10	0.98	-5.80	5.52	175.10	0.01	85.50	1.00	-5.30	
20	0.99	-12.40	5.53	169.40	0.02	80.70	0.99	-10.70	
30	0.98	-17.90	5.46	164.90	0.03	76.50	0.99	-16.10	
40	0.97	-24.10	5.40	159.80	0.04	71.80	0.98	-21.30	
50	0.96	-30.10	5.30	154.80	0.05	67.2	0.97	-26.30	
60	0.95	-36.10	5.17	149.80	0.06	62.90	0.95	-31.20	
70	0.93	-41.60	5.01	145.10	0.06	58.70	0.94	-35.80	
80	0.92	-46.40	4.83	141.00	0.07	55.10	0.93	-40.20	
90	0.91	-50.90	4.68	137.30	0.08	51.80	0.92	-44.50	
100	0.90	-55.20	4.55	133.60	0.08	48.50	0.90	-48.70	
125	0.87	-66.60	4.23	124.20	0.09	40.10	0.87	-58.40	
150	0.84	-76.70	3.85	115.60	0.10	32.70	0.84	-66.60	
175	0.82	-85.00	3.51	108.60	0.10	27.20	0.82	-74.00	
200	0.81	-92.70	3.23	102.10	0.11	22.00	0.81	-80.90	
250	0.78	-106.30	2.72	89.90	0.10	12.50	0.78	-92.10	
300	0.78	-117.30	2.33	80.30	0.10	6.10	0.78	-101.80	
350	0.77	-126.90	2.00	71.40	0.09	1.00	0.78	-109.70	
400	0.78	-135.60	1.74	63.90	0.08	-1.50	0.79	-116.80	
450	0.79	-143.20	1.53	56.80	0.06	-1.80	0.80	-123.00	
500	0.79	-150.30	1.36	51.00	0.05	2.10	0.81	-128.80	
600	0.81	-163.30	1.09	40.80	0.03	33.70	0.84	-139.00	
700	0.82	-175.10	0.89	32.70	0.05	74.30	0.86	-147.90	
800	0.83	173.80	0.74	26.80	0.08	87.20	0.87	-155.90	
900	0.83	163.20	0.63	23.00	0.11	86.30	0.89	-162.90	
1000	0.83	152.90	0.54	21.70	0.28	144.80	0.65	175.60	

Note

^{1.} For more extensive s-parameters see internet: http://www.semiconductors.philips.com/markets/communications/wirelesscommunication/broadcast.

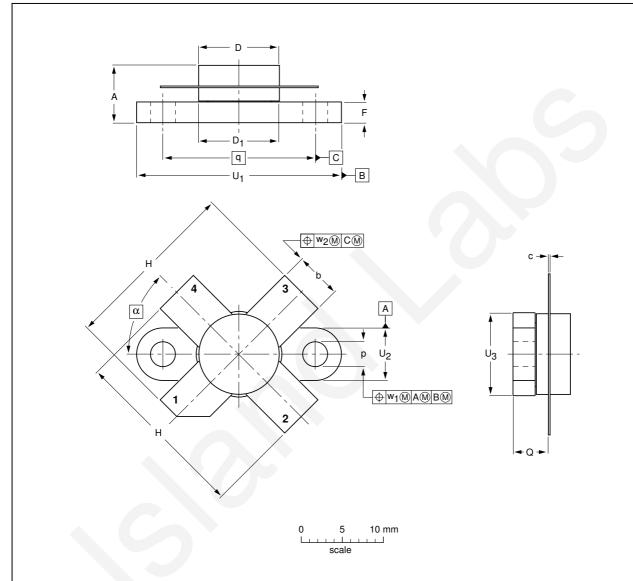
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PACKAGE OUTLINE

Flanged ceramic package; 2 mounting holes; 4 leads

SOT123A



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	Α	b	С	D	D ₁	F	н	р	Q	q	U ₁	U ₂	U ₃	w ₁	w ₂	α
mm	7.47 6.37	5.82 5.56	0.18 0.10	9.73 9.47	9.78 9.42	2.72 2.31	20.71 19.93	3.33 3.04	4.63 4.11	18.42	24.87 24.64	6.48 6.22	9.78 9.39	0.25	0.51	45°
inches	0.294 0.251	0.229 0.219	0.007 0.004	0.383 0.373			0.815 0.785			0.725	0.980 0.970	0.255 0.245	0.385 0.370	0.010	0.020	45

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT123A					99-03-29

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DATA SHEET STATUS

LEVEL	DATA SHEET STATUS(1)	PRODUCT STATUS(2)(3)	DEFINITION
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